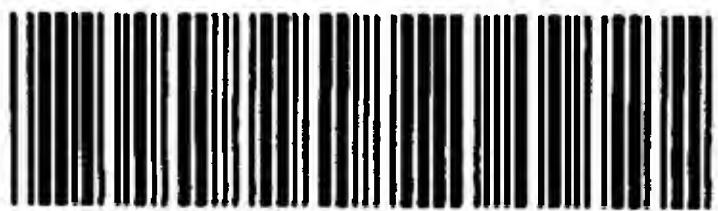


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10707397	TAI ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Liu, Lin	2145	

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
709	224	08/28/2007	L.L

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	08/28/2007	L.L
Limited classified search of 709/208-209, 219, 224-225	08/29/2007	L.L
L1: 709/224.ccls. and (@ad<20030903) reviewed consicely	08/28/2007	L.L
709/224.ccls. not L1, reviewed cursory.	08/28/2007	L.L
Diaglog search attached	08/29/2007	L.L

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>